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AMENDMENTS TO THE CLAIMS

1. (Currently Amended) An active pixel sensor, comprising:

a plurality of pixels, wherein each of said pixels comprises:

a reset circuit portion for supplying a reset signal and a photosensor charge accumulation signal to a column line resetting a photosensitive element of said pixel;

a first storage circuit for receiving said reset signal from said column line and storing [[a]] said reset signal, voltage level of said photosensitive element, wherein said first storage circuit comprising further comprises a first sample and hold circuit, wherein said first sample and hold circuit comprises a first sample and hold transistor switchably coupling a first terminal of a first storage capacitor with said column line reset portion; and

a second storage circuit for <u>receiving said photosensor charge accumulation signal</u> from said column line and storing <u>said photosensor charge accumulation signal</u>, a <u>voltage</u> level of said photosensitive element after an integration period, wherein said second storage circuit <u>comprising comprises</u> a second sample and hold circuit, wherein said second sample and hold circuit comprises a second sample and hold transistor switchably coupling a first terminal of a second storage capacitor with said-reset portion column line,

wherein said first and second storage circuits are configured to provide the signals respectively stored therein to said column line during a readout operation.

2. (Currently Amended) The active pixel sensor of claim 1, wherein said photosensitive element photosensor charge accumulation signal is generated by a photodiode.

Claims 3-5. (Canceled)

(Currently Amended) The active pixel sensor of claim 1, wherein said first terminal of said first storage capacitor is coupled to a gate of a first source follower transistor, a first source/drain terminal of said first source follower transistor is coupled to a supply voltage terminal,

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said column [[bus]] line.

6.

Claims 7-8. (Canceled)

9. (Currently Amended) The active pixel sensor of claim 1, wherein said first terminal of said second storage capacitor is coupled to a gate of a second source follower transistor, a first source/drain terminal of said second source follower transistor is coupled to a supply voltage terminal, and a second source/drain terminal of said second source follower transistor is switchably coupled to said column [[bus]] line.

and a second source/drain terminal of said first source follower transistor is switchably coupled to

Claims 10-16. (Canceled)

17. (Currently Amended) A semiconductor chip, comprising:

an active pixel sensor, said active pixel sensor comprising:

a plurality of pixels, wherein each of said pixels comprises comprising:

a reset circuit portion for supplying a reset signal and a photosensor charge accumulation signal to a column line resetting a photosensitive element of said pixel;

a first storage circuit for receiving said reset signal from said column line and storing [[a]] said reset signal, voltage level of said photosensitive element, wherein said first storage circuit comprising further comprises a first sample and hold circuit, wherein said first sample and hold circuit comprises a first sample and hold transistor switchably coupling a first terminal of a first storage capacitor with said reset portion column line; and

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a second storage circuit for <u>receiving said photosensor charge accumulation</u> signal from said column line and storing said photosensor charge accumulation signal, a voltage level of said photosensitive element after an integration period, wherein said second storage circuit <u>comprising comprises</u> a second sample and hold circuit, wherein said second sample and hold circuit comprises a second sample and hold transistor switchably coupling a first terminal of a second storage capacitor with said-reset portion column line,

wherein said first and second storage circuits are configured to provide the signals respectively stored therein to said column line during a readout operation.

18. (Currently Amended) The semiconductor chip of claim 17, wherein said photosensor charge accumulation signal photosensitive element is generated by a photodiode.

Claims 19-21. (Canceled)

22. (Currently Amended) The semiconductor chip of claim 17, wherein said first terminal of said first storage capacitor is coupled to a gate of a first source follower transistor, a first source/drain terminal of said first source follower transistor is coupled to a supply voltage terminal, and a second source/drain terminal of said first source follower transistor is switchably coupled to said column [[bus]] line.

Claims 23-24. (Canceled)

25. (Currently Amended) The semiconductor chip of claim 17, wherein said first terminal of said second storage capacitor is coupled to a gate of a second source follower transistor, a first source/drain terminal of said second source follower transistor is coupled to a supply voltage terminal, and a second source/drain terminal of said second source follower transistor is switchably coupled to said column [[bus]] line.

Claims 26-32. (Canceled)

33. (Currently Amended) A processor system, comprising:

a processor; and

an imager device coupled to said processor for sending signals to said processor, said imager device comprising:

a plurality of pixels, wherein-each of said pixels comprising comprises:

a <u>circuit</u> reset portion for <u>supplying a reset signal and a photosensor charge</u> accumulation signal to a column line resetting a photosensitive element of said pixel;

a first storage circuit for <u>receiving said reset signal from said column line and</u> storing [[a]] <u>said</u> reset <u>signal</u>, <u>voltage level of said photosensitive element</u>, <u>wherein said</u> first storage circuit <u>comprising</u> <u>further comprises a first sample and hold circuit</u>, <u>wherein said</u> <u>first sample and hold circuit comprises</u> a first sample and hold transistor switchably coupling a first terminal of a first storage capacitor with said <u>reset portion column line</u>; and

a second storage circuit for <u>receiving said photosensor charge accumulation</u> signal from said column line and storing said photosensor charge accumulation signal, a voltage level of said photosensitive element after an integration period, wherein said second storage circuit <u>comprising comprises</u> a second sample and hold circuit, wherein said second sample and hold circuit comprises a second sample and hold transistor switchably coupling a first terminal of a second storage capacitor with said-reset portion column line,

wherein said first and second storage circuits are configured to provide the signals respectively stored therein to said column line during a readout operation.

34. (Currently Amended) The processor system of claim 33, wherein said <u>photosensor</u> charge accumulation signal photosensitive element is generated by a photodiode.

Claims 35-37. (Canceled)

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38. (Currently Amended) The processor system of claim 33, wherein said first terminal of said first storage capacitor is coupled to a gate of a first source follower transistor, a first source/drain terminal of said first source follower transistor is coupled to a supply voltage terminal, and a second source/drain terminal of said first source follower transistor is switchably coupled to said column [[bus]] line.

Claims 39-40. (Canceled)

41. (Currently Amended) The processor system of claim 33, wherein said first terminal of said second storage capacitor is coupled to a gate of a second source follower transistor, a first source/drain terminal of said second source follower transistor is coupled to a supply voltage terminal, and a second source/drain terminal of said second source follower transistor is switchably coupled to said column [[bus]] <u>line</u>.

Claims 42-48. (Canceled)

49. (Currently Amended) A method [[for]] of operating an active pixel sensor, the method comprising:

resetting a photosensitive element of a pixel-within a reset portion, wherein said pixel comprises comprising a circuit portion, a first storage circuit and a second storage circuit;

transferring a reset signal from the circuit portion to a column line;

receiving the reset signal from the column line at the first storage circuit;

storing [[a]] <u>said</u> reset <u>signal voltage of said photosensitive element</u> within said first storage circuit, <u>wherein said</u> first storage circuit <u>comprising comprises a first sample and hold</u> eircuit, <u>wherein said first sample and hold circuit comprises</u> a first sample and hold transistor switchably coupling a first terminal of a first storage capacitor with said <u>reset portion</u> column line;

exposing said photosensitive element to a light source during an integration period while said reset voltage signal is stored within said pixel; and

transferring a charge accumulation signal from the circuit portion to a column line; receiving the charge accumulation signal from the column line at the second storage circuit;

storing within said second storage circuit [[a]] said charge accumulation signal voltage level of said photosensitive element after said integration period, said reset voltage signal still being stored within said first storage circuit, wherein said second storage circuit comprising comprises a second sample and hold circuit, wherein said second sample and hold circuit comprises a second sample and hold transistor switchably coupling a first terminal of a second storage capacitor with said reset portion column line; and

reading out said reset signal on said column line.

(Currently Amended) The method of claim 49 further comprising: 50.

reading out-said reset voltage from said pixel;

reading out said voltage level of said photosensitive element after said integration period; and

generating a difference signal corresponding to a level of light to which said photosensitive element was exposed during said integration period.

Claim 51-53. (Canceled)